

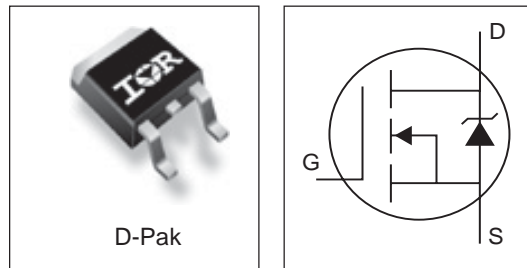
- N-Channel Application-Specific MOSFETs
- Ideal for CPU Core DC-DC Converters
- Low Conduction Losses
- Low Switching Losses
- Minimizes Parallel MOSFETs for high current applications
- 100% R<sub>G</sub> Tested

**Description**

This new device employs advanced HEXFET Power MOSFET technology to achieve an unprecedented balance of on-resistance and gate charge. The reduced conduction and switching losses make it ideal for high efficiency DC-DC converters that power the latest generation of microprocessors.

The IRLR8103V has been optimized for all parameters that are critical in synchronous buck converters including R<sub>DS(on)</sub>, gate charge and Cdv/dt-induced turn-on immunity. The IRLR8103V offers an extremely low combination of Q<sub>sw</sub> & R<sub>DS(on)</sub> for reduced losses in both control and synchronous FET applications.

The package is designed for vapor phase, infra-red, convection, or wave soldering techniques. Power dissipation of greater than 2W is possible in a typical PCB mount application.



**DEVICE CHARACTERISTICS** ⑤

|                     | <b>IRLR8103V</b> |
|---------------------|------------------|
| R <sub>DS(on)</sub> | 7.9 mΩ           |
| Q <sub>G</sub>      | 27 nC            |
| Q <sub>SW</sub>     | 12 nC            |
| Q <sub>OSS</sub>    | 29nC             |

**Absolute Maximum Ratings**

| Parameter   | Symbol                            | IRLR8103V  | Units |
|---|-----------------------------------|------------|-------|
| Drain-Source Voltage  | V <sub>DS</sub>                   | 30         | V     |
| Gate-Source Voltage   | V <sub>GS</sub>                   | ±20        |       |
| Continuous Drain or Source Current<br>(V <sub>GS</sub> > 10V) | I <sub>D</sub>                    | TC = 25°C  | A     |
|   |                                   | TC = 90°C  |       |
| Pulsed Drain Current ①  | I <sub>DM</sub>                   | 363        |       |
| Power Dissipation ③   | P <sub>D</sub>                    | TC = 25°C  | W     |
|   |                                   | TC = 90°C  |       |
| Junction & Storage Temperature Range                          | T <sub>J</sub> , T <sub>STG</sub> | -55 to 150 | °C    |
| Continuous Source Current (Body Diode)                        | I <sub>S</sub>                    | 91         | A     |
| Pulsed Source Current ①                                       | I <sub>SM</sub>                   | 363        |       |

**Thermal Resistance**

| Parameter                      | Symbol           | Typ. | Max. | Units |
|--------------------------------|------------------|------|------|-------|
| Maximum Junction-to-Ambient ③⑥ | R <sub>θJA</sub> | —    | 50   | °C/W  |
| Maximum Junction-to-Case ⑥     | R <sub>θJC</sub> | —    | 1.09 |       |

## Electrical Characteristics

| Parameter                            | Symbol       | Min | Typ  | Max       | Units      | Conditions                                    |
|--------------------------------------|--------------|-----|------|-----------|------------|---|
| Drain-to-Source Breakdown Voltage    | $V_{DSS}$    | 30  | —    | —         | V          | $V_{GS} = 0V, I_D = 250\mu A$                 |
| Static Drain-Source On-Resistance    | $R_{DS(on)}$ | —   | 6.9  | 9.0       | m $\Omega$ | $V_{GS} = 10V, I_D = 15A$ ②                   |
|                                      |              | —   | 7.9  | 10.5      |            | $V_{GS} = 4.5V, I_D = 15A$ ②                  |
| Gate Threshold Voltage               | $V_{GS(th)}$ | 1.0 | —    | 3.0       | V          | $V_{DS} = V_{GS}, I_D = 250\mu A$             |
| Drain-to-Source Leakage Current      | $I_{DSS}$    | —   | —    | 50        | $\mu A$    | $V_{DS} = 30V, V_{GS} = 0V$                   |
|                                      |              | —   | —    | 20        | $\mu A$    | $V_{DS} = 24V, V_{GS} = 0$                    |
|                                      |              | —   | —    | 100       |            | $V_{DS} = 24V, V_{GS} = 0, T_J = 100^\circ C$ |
| Gate-Source Leakage Current          | $I_{GSS}$    | —   | —    | $\pm 100$ | nA         | $V_{GS} = \pm 20V$                            |
| Total Gate Charge, Control FET       | $Q_G$        | —   | 27   | —         | nC         | $V_{GS} = 5V, I_D = 15A, V_{DS} = 16V$        |
| Total Gate Charge, Synch FET         | $Q_G$        | —   | 23   | —         |            | $V_{GS} = 5V, V_{DS} < 100mV$                 |
| Pre-Vth Gate-Source Charge           | $Q_{GS1}$    | —   | 4.7  | —         |            | $V_{DS} = 16V, I_D = 15A$                     |
| Post-Vth Gate-Source Charge          | $Q_{GS2}$    | —   | 2.0  | —         |            |   |
| Gate to Drain Charge                 | $Q_{GD}$     | —   | 9.7  | —         |            |   |
| Switch Charge ( $Q_{gs2} + Q_{gd}$ ) | $Q_{SW}$     | —   | 12   | —         |            |   |
| Output Charge                        | $Q_{OSS}$    | —   | 29   | —         |            |   |
| Gate Resistance                      | $R_G$        | 0.8 | —    | 3.1       |            | $\Omega$                                      |
| Turn-On Delay Time                   | $t_{d(on)}$  | —   | 10   | —         | ns         | $V_{DD} = 16V$                                |
| Rise Time                            | $t_r$        | —   | 9    | —         |            | $I_D = 15A$                                   |
| Turn-Off Delay Time                  | $t_{d(off)}$ | —   | 24   | —         |            | $V_{GS} = 5.0V$                               |
| Fall Time                            | $t_f$        | —   | 18   | —         |            | Clamped Inductive Load                        |
| Input Capacitance                    | $C_{iss}$    | —   | 2672 | —         | pF         | $V_{GS} = 16V, V_{GS} = 0$                    |
| Output Capacitance                   | $C_{oss}$    | —   | 1064 | —         |            |   |
| Reverse Transfer Capacitance         | $C_{rss}$    | —   | 109  | —         |            |   |

## Source-Drain Rating & Characteristics

| Parameter  | Symbol      | Min | Typ | Max | Units | Conditions  |
|--|-------------|-----|-----|-----|-------|---|
| Diode Forward Voltage                              | $V_{SD}$    | —   | 0.9 | 1.3 | V     | $I_S = 15A$ ②, $V_{GS} = 0V$  |
| Reverse Recovery Charge ④                          | $Q_{rr}$    | —   | 103 | —   | nC    | $di/dt \sim 700A/\mu s$<br>$V_{DS} = 16V, V_{GS} = 0V, I_F = 15A$               |
| Reverse Recovery Charge (with Parallel Schottky) ④ | $Q_{rr(s)}$ | —   | 96  | —   | nC    | $di/dt = 700A/\mu s$ , (with 10BQ040)<br>$V_{DS} = 16V, V_{GS} = 0V, I_F = 15A$ |

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- ③ When mounted on 1 inch square copper board,  $t < 10$  sec.
- ④ Typ = measured -  $Q_{oss}$
- ⑤ Typical values of  $R_{DS(on)}$  measured at  $V_{GS} = 4.5V$ ,  $Q_G$ ,  $Q_{SW}$  and  $Q_{OSS}$  measured at  $V_{GS} = 5.0V$ ,  $I_F = 15A$ .
- ⑥  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ C$

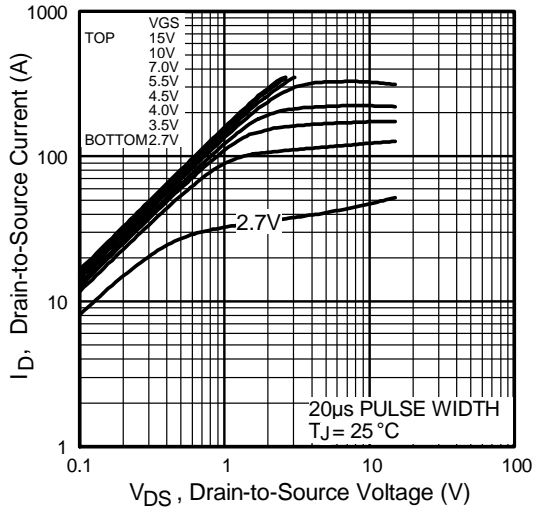


Fig 1. Typical Output Characteristics

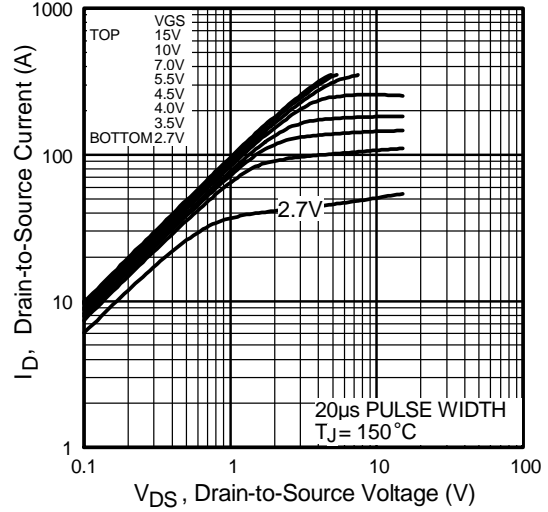


Fig 2. Typical Output Characteristics

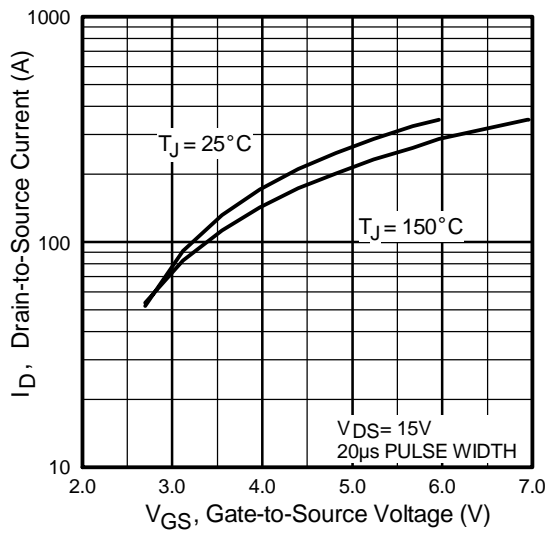


Fig 3. Typical Transfer Characteristics

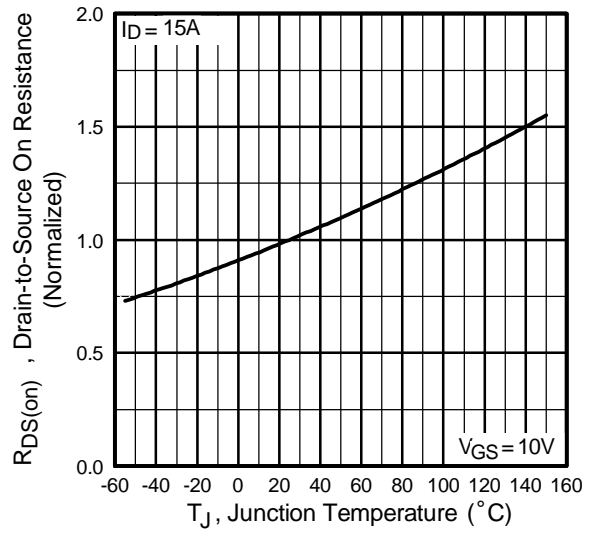
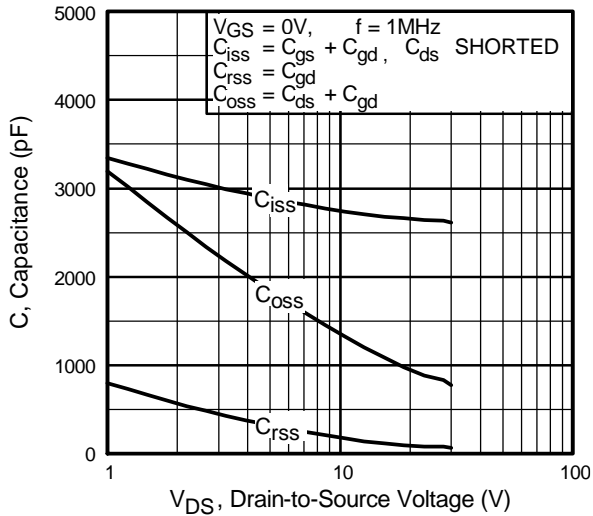
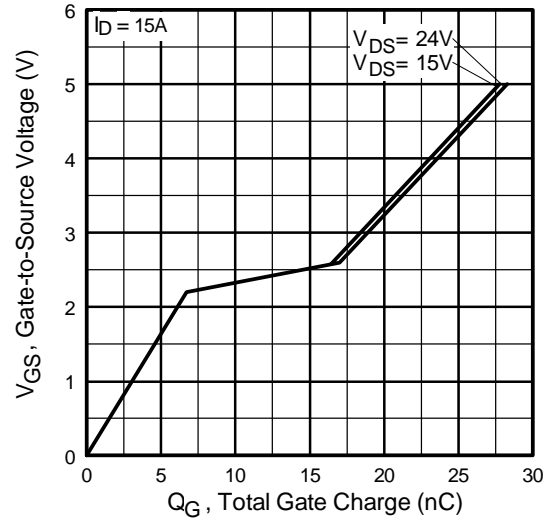


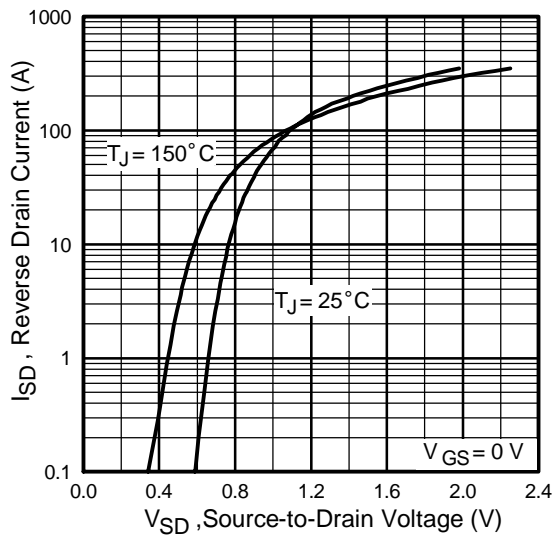
Fig 4. Normalized On-Resistance Vs. Temperature



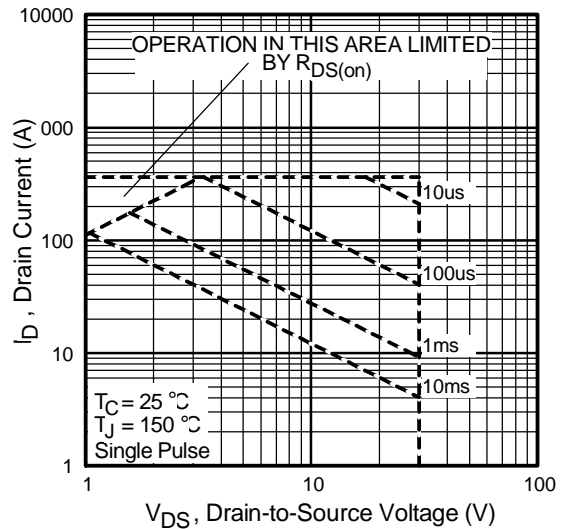
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 8.** Maximum Safe Operating Area

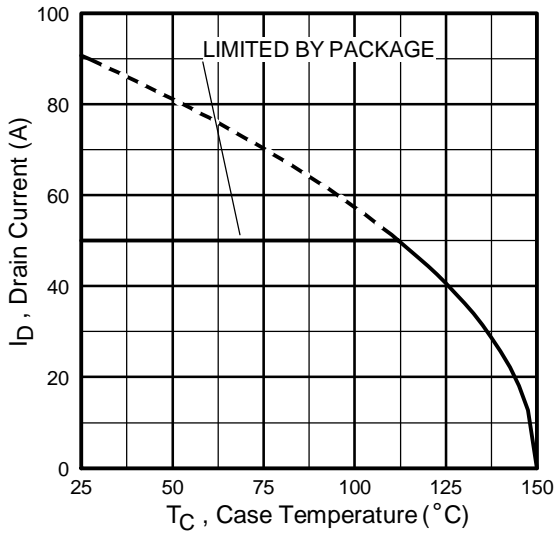


Fig 9. Maximum Drain Current Vs. Case Temperature

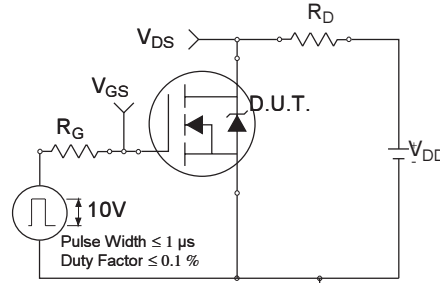


Fig 10a. Switching Time Test Circuit

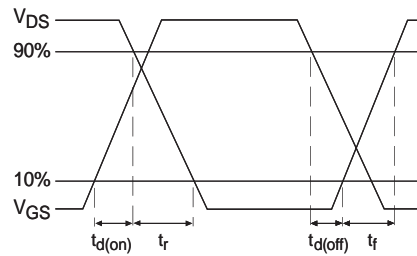


Fig 10b. Switching Time Waveforms

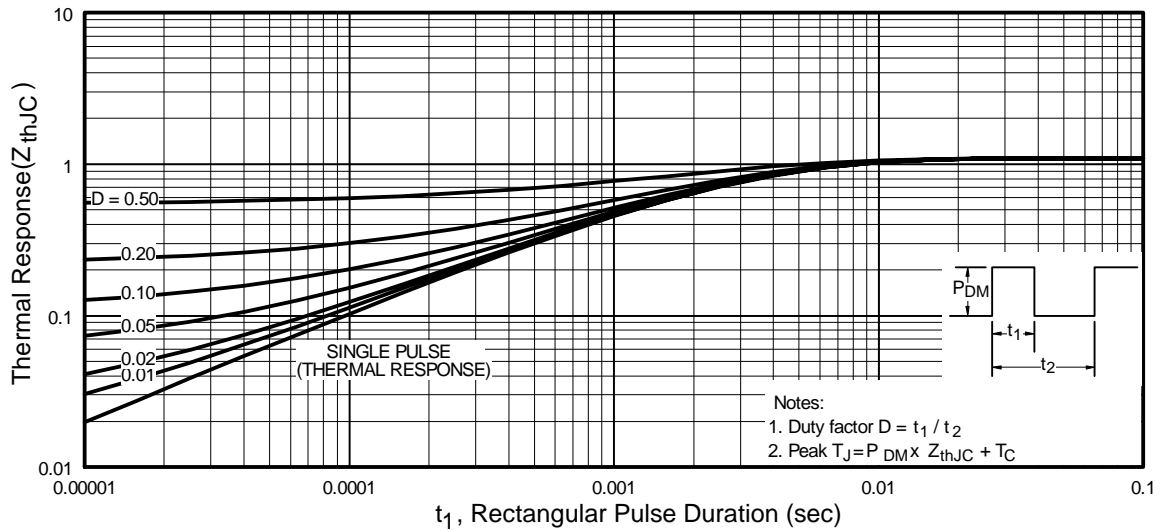
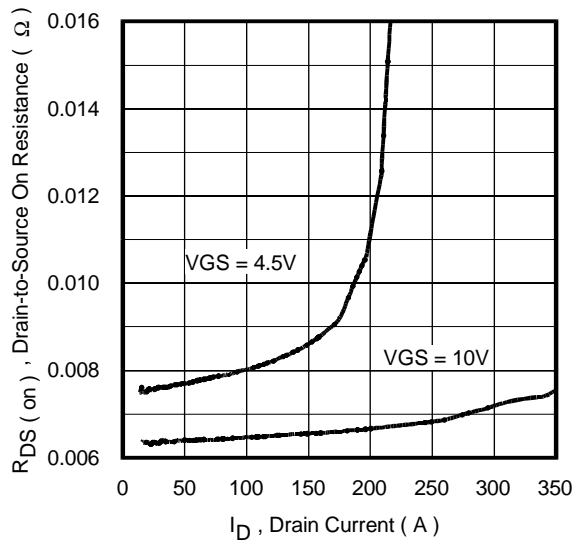
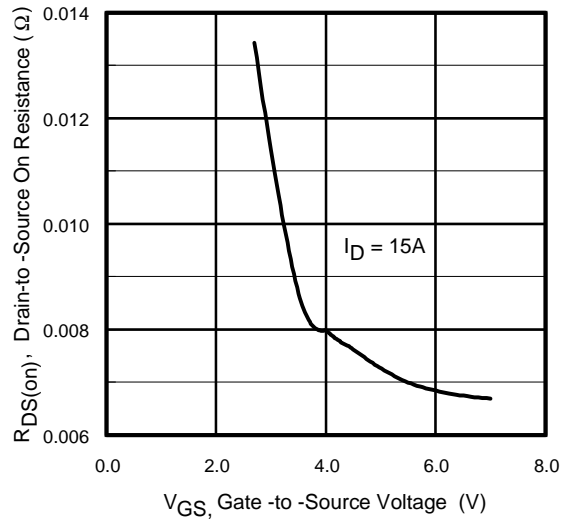


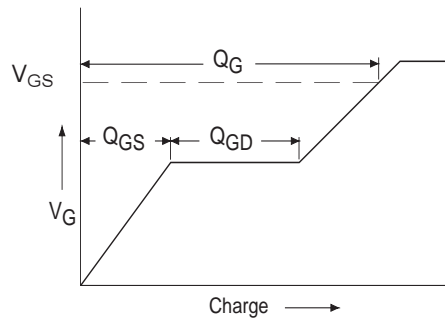
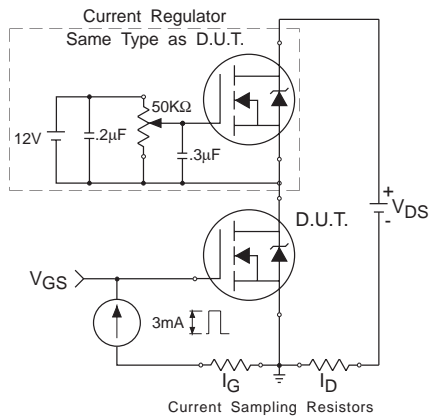
Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



**Fig 12.** On-Resistance Vs. Drain Current



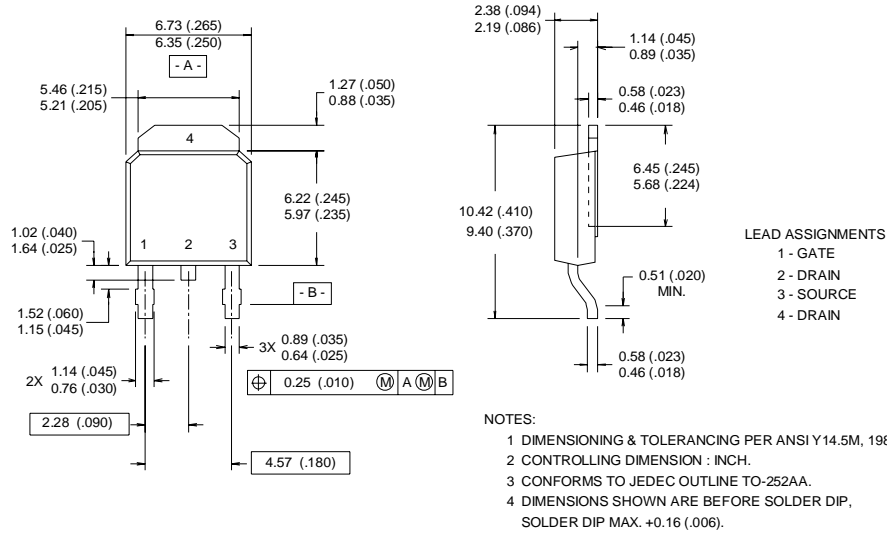
**Fig 13.** On-Resistance Vs. Gate Voltage



**Fig 14a&b.** Basic Gate Charge Test Circuit and Waveform

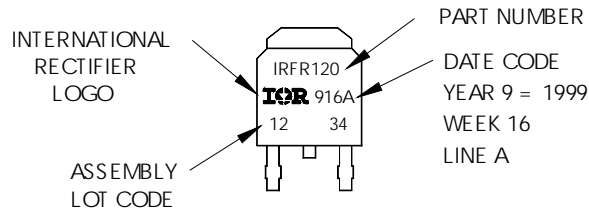
## D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)

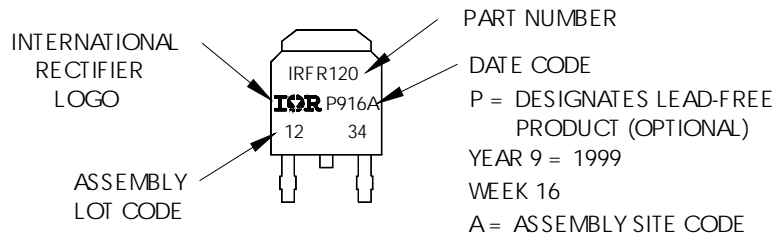


## D-Pak (TO-252AA) Part Marking Information

EXAMPLE: THIS IS AN IRFR120  
 WITH ASSEMBLY  
 LOT CODE 1234  
 ASSEMBLED ON WW 16, 1999  
 IN THE ASSEMBLY LINE "A"  
 Note: "P" in assembly line  
 position indicates "Lead-Free"



**OR**

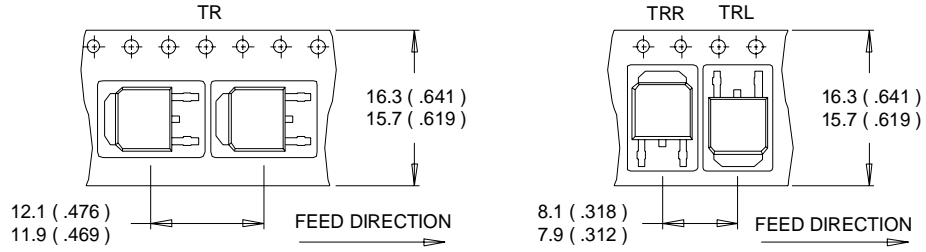


# IRLR8103V

International  
**IR** Rectifier

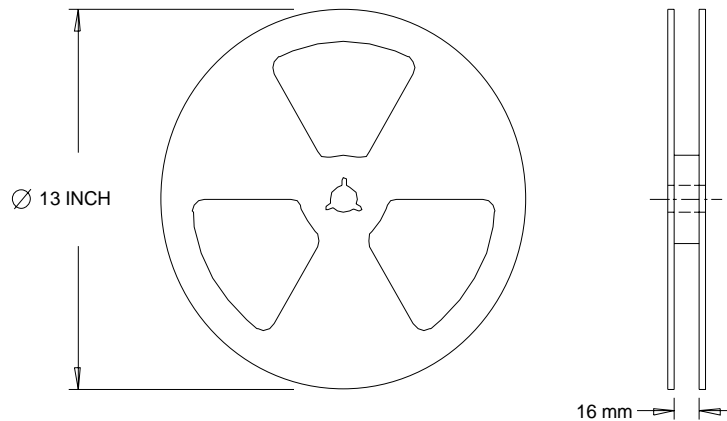
## D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. OUTLINE CONFORMS TO EIA-481.

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Industrial market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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Visit us at [www.irf.com](http://www.irf.com) for sales contact information. 10/04



Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>